

## Self-Protected Low Side Driver with Temperature and Current Limit

### NCV8402, NCV8402A

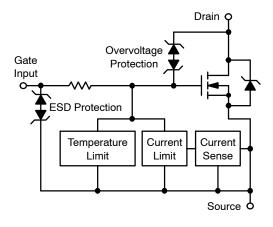
NCV8402/A is a three terminal protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

#### **Features**

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- NCV8402AMNWT1G Wettable Flanks Product
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial



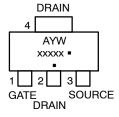
V <sub>(BR)DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
42 V	165 mΩ @ 10 V	2.0 A*

<sup>\*</sup>Max current limit value is dependent on input condition.

#### **MARKING DIAGRAMS**



SOT-223 CASE 318E STYLE 3





DFN6 CASE 506AX





DFN6 (WF) CASE 506DK



A = Assembly Location

/ = Year

W or WW = Work Week xxxxx = V8402 or 8402A

■ = Pb-Free Package

(Note: Microdot may be in either location)

#### **DFN6 PACKAGE PIN DESCRIPTION**

G	NC	NC
1	2	3
_	7	$\neg$
[	EPAI	o
6	5	4
S	S	S

1

Pin#	Symbol	Description
1	G	Gate Input
2	NC	No Connect
3	NC	No Connect
4	S*	Source
5	S*	Source
6	S*	Source
7	EPAD	Drain

\*Pins 4, 5, 6 are internally shorted together. It is recommended to short these pins externally.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 11 of this data sheet.

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating				Value	Unit
Drain-to-Source Voltage Internally Cl	amped		$V_{DSS}$	42	V
Drain-to-Gate Voltage Internally Clan	nped	$(R_G = 1.0 M\Omega)$	$V_{DGR}$	42	V
Gate-to-Source Voltage			V <sub>GS</sub>	±14	V
Continuous Drain Current			I <sub>D</sub>	Internally L	imited
Total Power Dissipation – SOT–223 Version @ $T_A$ = 25°C (Note 1) @ $T_A$ = 25°C (Note 2) @ $T_S$ = 25°C)		P <sub>D</sub>	1.1 1.74 8.9	W	
Fotal Power Dissipation – DFN Version 0 T <sub>A</sub> = 25°C (Note 1) 0 T <sub>A</sub> = 25°C (Note 2) 0 T <sub>S</sub> = 25°C)			P <sub>D</sub>	0.76 1.78 8.9	W
Maximum Continuous Drain Current – SOT–223 Version @ $T_A$ = 25°C (Note 1) @ $T_A$ = 25°C (Note 2) @ $T_S$ = 25°C)			Ι <sub>D</sub>	1.54 1.94 6.75	Α
Maximum Continuous Drain Current – DFN Version @ $T_A = 25^{\circ}C$ (Note 1) @ $T_A = 25^{\circ}C$ (Note 2) @ $T_S = 25^{\circ}C$ )			Ι <sub>D</sub>	1.28 1.97 6.75	Α
Thermal Resistance SOT223 Junction-to-Ambient Steady State (Note 1) SOT223 Junction-to-Ambient Steady State (Note 2) SOT223 Junction-to-Soldering Point Steady State		-Ambient Steady State (Note 2)	$egin{aligned} R_{ hetaJA}\ R_{ hetaJS} \end{aligned}$	114 72 14	°C/W
	DFN Junction-to-	-Ambient Steady State (Note 1) -Ambient Steady State (Note 2) o-Soldering Point Steady State	$egin{aligned} R_{ hetaJA} \ R_{ hetaJS} \end{aligned}$	163 70 14	
Single Pulse Drain-to–Source Avalanche Energy (V <sub>DD</sub> = 32 V, V <sub>G</sub> = 5.0 V, I <sub>PK</sub> = 1.0 A, L = 300 mH, R <sub>G(ext)</sub> = 25 $\Omega$ )			E <sub>AS</sub>	150	mJ
Load Dump Voltage	$(V_{GS} = 0 \text{ and } 10 \text{ V}, R_I =$	2.0 Ω, $R_L$ = 9.0 Ω, $t_d$ = 400 ms)	$V_{LD}$	55	V
Operating Junction Temperature			TJ	-40 to 150	°C
Storage Temperature			T <sub>stg</sub>	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

2. Surface-mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

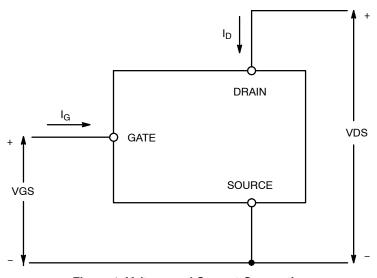


Figure 1. Voltage and Current Convention

#### $\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Parameter	Parameter Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	V <sub>(BR)DSS</sub>	42	46	55	V
(Note 3)	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>J</sub> = 150°C (Note 5)		40	45	55	
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I <sub>DSS</sub>		0.25	4.0	μΑ
Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 32 V, T <sub>J</sub> = 150°C (Note 5)	I <sub>DSS</sub>		1.1	20	μΑ
Gate Input Current	$V_{DS} = 0 \text{ V}, V_{GS} = 5.0 \text{ V}$	I <sub>GSSF</sub>		50	100	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 150 \mu A$	V <sub>GS(th)</sub>	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V <sub>GS(th)</sub> /T <sub>J</sub>		4.0		-mV/°C
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$	R <sub>DS(on)</sub>		165	200	mΩ
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			305	400	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 25°C			195	230	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			360	460	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 0.5 A, T <sub>J</sub> = 25°C			190	230	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 0.5 A, T <sub>J</sub> = 150°C (Note 5)			350	460	
Source-Drain Forward On Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.0 A	$V_{SD}$		1.0		V
SWITCHING CHARACTERISTICS (Note	5)		•			
Turn-On Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )		t <sub>on</sub>		25	30	μs
Turn-Off Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )		t <sub>off</sub>		120	200	μs
Turn-On Rise Time (10% I <sub>D</sub> to 90% I <sub>D</sub> )	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 12 V,	t <sub>rise</sub>		20	25	μs
Turn-Off Fall Time (90% I <sub>D</sub> to 10% I <sub>D</sub> )	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t <sub>fall</sub>		50	70	μs
Slew-Rate ON (70% to 50% V <sub>DD</sub> )		-dV <sub>DS</sub> /dt <sub>ON</sub>		0.8	1.2	V/μs
Slew-Rate OFF (50% to 70% V <sub>DD</sub> )		dV <sub>DS</sub> /dt <sub>OFF</sub>		0.3	0.5	V/μs
SELF PROTECTION CHARACTERISTIC	S (T <sub>J</sub> = 25°C unless otherwise noted) (	Note 4)				
Current Limit	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 25°C (Note 6)	I <sub>LIM</sub>	3.7	4.3	5.0	А
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 150°C (Notes 5, 6)		2.3	3.0	3.7	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 25°C (Note 6)		4.2	4.8	5.4	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 150°C (Notes 5, 6)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V <sub>GS</sub> = 5.0 V (Notes 5, 6)	T <sub>LIM(off)</sub>	150	175	200	°C
Thermal Hysteresis	V <sub>GS</sub> = 5.0 V	$\Delta T_{LIM(on)}$		15		
Temperature Limit (Turn-off)	V <sub>GS</sub> = 10 V (Notes 5, 6)	T <sub>LIM(off)</sub>	150	165	185	
Thermal Hysteresis	V <sub>GS</sub> = 10 V	$\Delta T_{LIM(on)}$		15		<u></u>
GATE INPUT CHARACTERISTICS (Note	= 5)					
Device ON Gate Input Current	V <sub>GS</sub> = 5 V I <sub>D</sub> = 1.0 A	I <sub>GON</sub>		50		μΑ
	V <sub>GS</sub> = 10 V I <sub>D</sub> = 1.0 A			400		1

- Pulse Test: Pulse Width ≤300 µs, Duty Cycle ≤ 2%.
   Fault conditions are viewed as beyond the normal operating range of the part.
   Not subject to production testing.
   Refer to Application Note AND8202/D for dependence of protection features on gate voltage.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
GATE INPUT CHARACTERISTICS (Note	5)	-				
Current Limit Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I <sub>GCL</sub>		0.05		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V	7		0.4		
Thermal Limit Fault Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GTL</sub>		0.15		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V	7		0.7		
ESD ELECTRICAL CHARACTERISTICS	(T <sub>J</sub> = 25°C unless otherwise noted)	(Note 5)				
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
	Machine Model (MM)		400			1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Pulse Test: Pulse Width ≤[300 μs, Duty Cycle ≤ 2%.
   Fault conditions are viewed as beyond the normal operating range of the part.
- 5. Not subject to production testing.6. Refer to Application Note AND8202/D for dependence of protection features on gate voltage.

#### **TYPICAL PERFORMANCE CURVES**

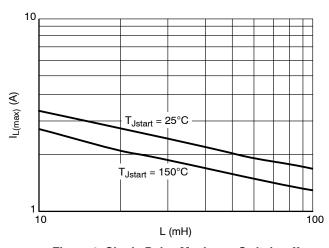


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

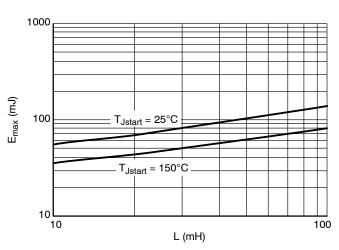


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

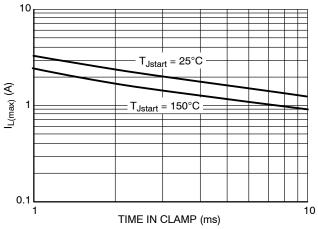


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

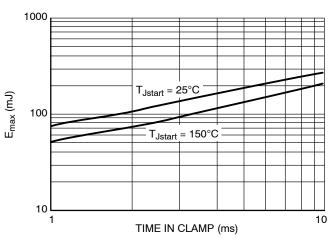


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

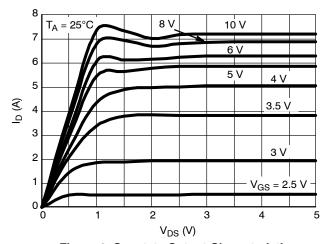


Figure 6. On-state Output Characteristics

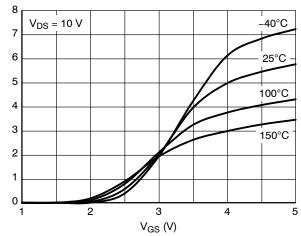


Figure 7. Transfer Characteristics

I<sub>D</sub> (A)

#### **TYPICAL PERFORMANCE CURVES**

I⊔M (A)

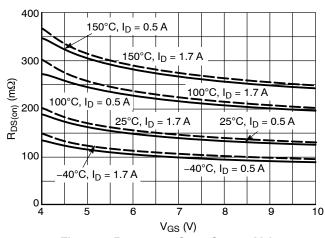


Figure 8.  $R_{DS(on)}$  vs. Gate-Source Voltage

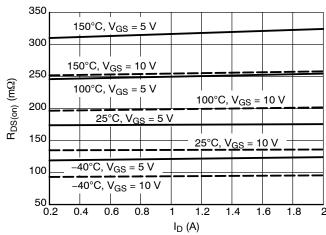


Figure 9. R<sub>DS(on)</sub> vs. Drain Current

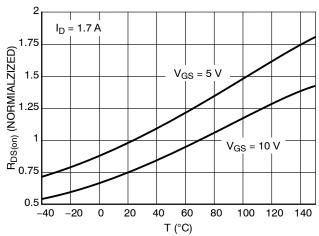


Figure 10. Normalized R<sub>DS(on)</sub> vs. Temperature

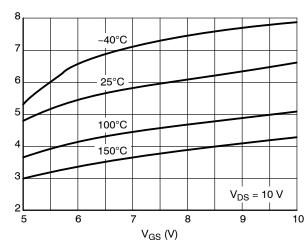


Figure 11. Current Limit vs. Gate-Source Voltage

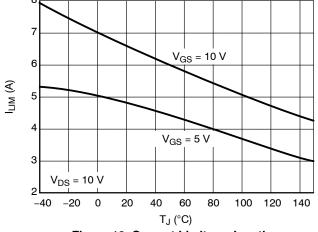


Figure 12. Current Limit vs. Junction Temperature

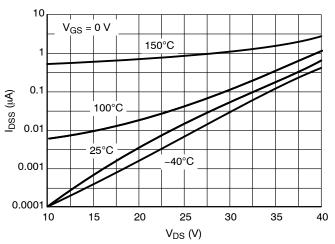


Figure 13. Drain-to-Source Leakage Current

#### **TYPICAL PERFORMANCE CURVES**

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

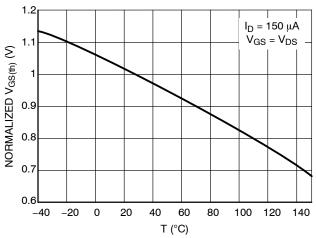


Figure 14. Normalized Threshold Voltage vs. Temperature

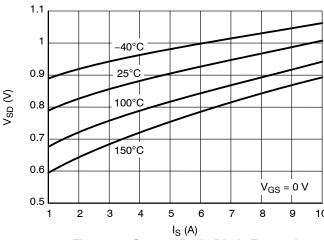


Figure 15. Source-Drain Diode Forward Characteristics

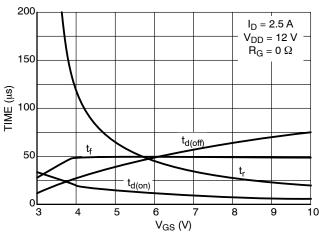


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

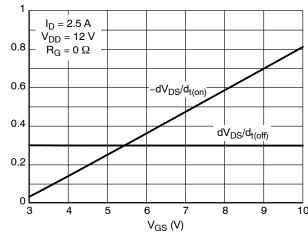


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

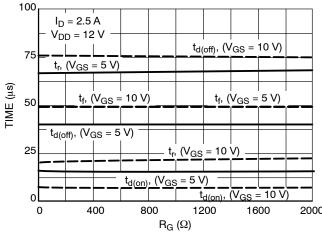


Figure 18. Resistive Load Switching Time vs.
Gate Resistance

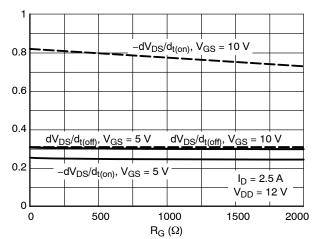


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

DRAIN-SOURCE VOLTAGE SLOPE (V/μs)

#### **TYPICAL PERFORMANCE CURVES**

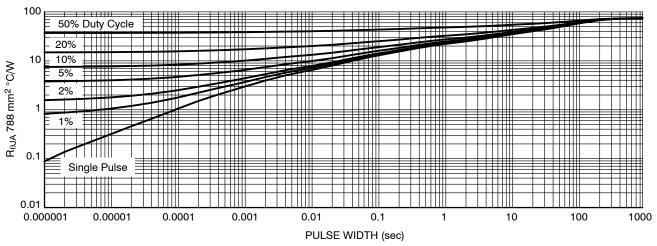


Figure 20. Transient Thermal Resistance - SOT-223 Package

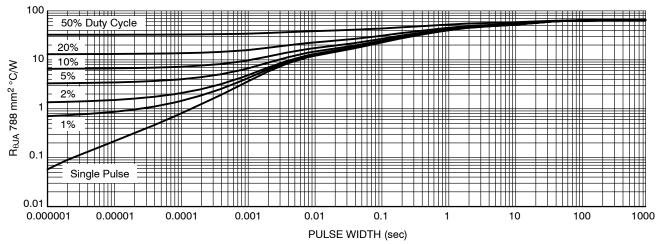


Figure 21. Transient Thermal Resistance - DFN Package

#### **TEST CIRCUITS AND WAVEFORMS**

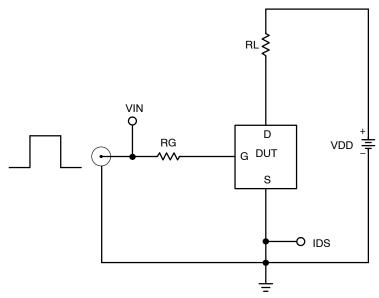


Figure 22. Resistive Load Switching Test Circuit

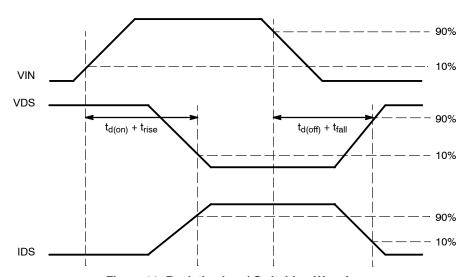


Figure 23. Resistive Load Switching Waveforms

#### **TEST CIRCUITS AND WAVEFORMS**

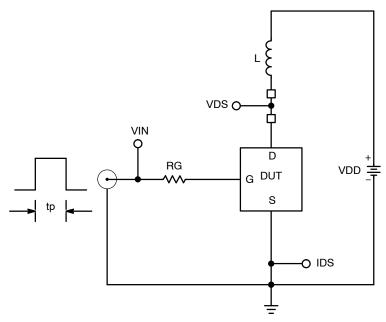


Figure 24. Inductive Load Switching Test Circuit

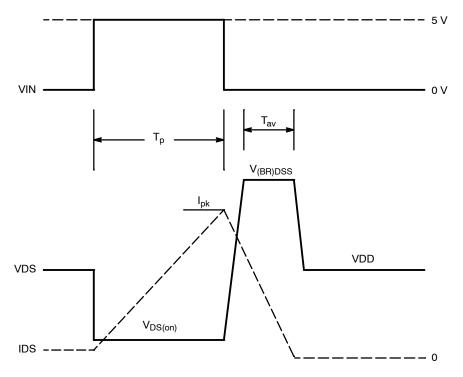


Figure 25. Inductive Load Switching Waveforms

#### **ORDERING INFORMATION**

Device*	Package	Shipping <sup>†</sup>
NCV8402STT1G	SOT-223	1000 / Tape & Reel
NCV8402ASTT1G	(Pb-Free)	
NCV8402STT3G	SOT-223	4000 / Tape & Reel
NCV8402ASTT3G	(Pb-Free)	
NCV8402AMNT2G	DFN6 (Pb-Free)	2000 / Tape & Reel
NCV8402AMNWT1G	DFN6 (Pb-Free, Wettable Flank)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
\*NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP

Capable.

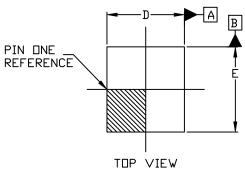
#### PACKAGE DIMENSIONS

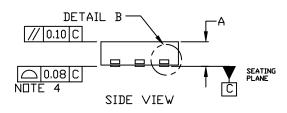
#### DFN6 3.0x3.3, 0.95P CASE 506AX

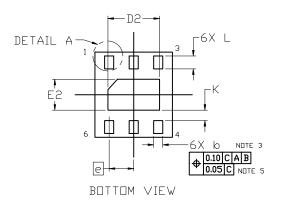
**ISSUE A** 

**DATE 22 SEP 2020** 



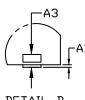






NDTES:

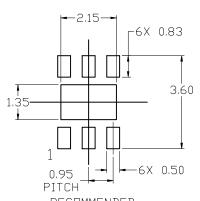
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
  DIMENSION & APPLIES TO PLATED TERMINALS AND IS
  MEASURED BETWEEN 0.15 AND 0.30MM FROM THE
- TERMINAL TIP.
  COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- POSITIONAL TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.



DETAIL B



	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
Α	0.80	0.90	1.00		
A1	0.00		0.05		
b	0.30	0.35	0.40		
D	2.90	3.00	3.10		
D2	1.90	2.00	2.10		
E	3,20	3,30	3.40		
E2	1.10	1.20	1.30		
e		0.95 BSC	,		
К	0.40 REF				
L	0.40	0.50	0.60		
L1	0.00		0.15		



RECOMMENDED MOUNTING FOOTPRINT

#### **GENERIC MARKING DIAGRAM\***

XXXXX XXXXX AYWW= XXXX = Specific Device Code

= Assembly Location = Year

= Work Week WW

= Pb-Free Package (Note: Microdot may be in either location) For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

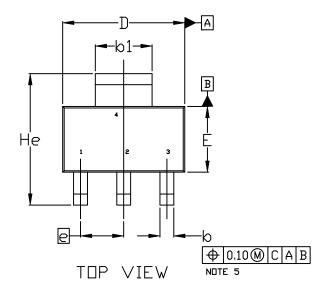
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

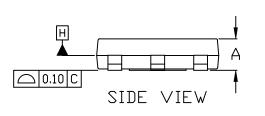


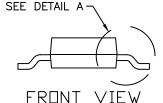


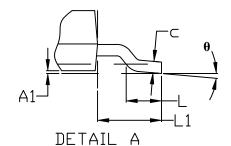
SOT-223 (TO-261) CASE 318E-04 ISSUE R

**DATE 02 OCT 2018** 





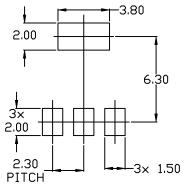




#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
  MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. AI IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
Α	1.50	1.63	1.75		
A1	0.02	0.06	0.10		
Ø	0.60	0.75	0.89		
b1	2.90	3.06	3.20		
U	0.24	0.29	0.35		
D	6.30	6.50	6.70		
Е	3.30	3.50	3.70		
е		2,30 BSC	,		
L	0.20				
L1	1.50	1.75	2.00		
He	6.70	7.00	7.30		
θ	0°		10°		



RECOMMENDED MOUNTING FOOTPRINT

DOCUMENT NUMBER:	98ASB42680B	Electronic versions are uncontrolled except when accessed directly from the Document Reposition Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	SOT-223 (TO-261)		PAGE 1 OF 2	

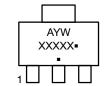
onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

#### **SOT-223 (TO-261)** CASE 318E-04 ISSUE R

**DATE 02 OCT 2018** 

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

# GENERIC MARKING DIAGRAM\*



A = Assembly Location

Y = Year W = Work Week

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location) \*This information is generic. Please refer to

device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98ASB42680B	Electronic versions are uncontrolled except when accessed directly from the Document Repos Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	SOT-223 (TO-261)		PAGE 2 OF 2		

onsemi and Onsemi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.



# SCALE 2:4

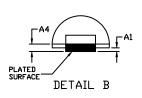
#### DFNW6 3x3, 0.95P

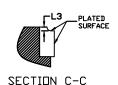
CASE 506DK ISSUE A

**DATE 07 MAY 2021** 

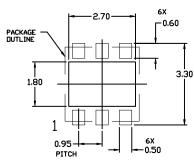
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 0.10 AND 0.20mm FROM THE TERMINAL TIP.
- 4. PROFILE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.





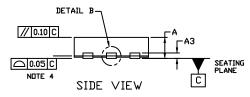
	MILLIMETERS		
DIM	MIN.	MAX.	MAX.
Α	0.75	0.85	0.95
A1	0.00		0.05
АЗ	0.20 REF		
A4	0.10		
b	0.35	0.40	0.45
D	3.00 BSC		
D2	2.40	2.50	2.60
Ε	3.00 B2C		
E2	1.50	1.60	1.70
e	0.95 BSC		
L	0.30	0.40	0.50
L3	0.00	0.05	0.10

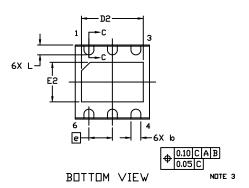


# RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

# PIN DNE REFERENCE 2X \( \times 0.10 \times \) TOP VIEW





# GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code

A = Assembly Location

L = Wafer Lot
Y = Year
W = Work Week
= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON12549G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFNW6 3X3, 0.95P		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

#### ADDITIONAL INFORMATION

**TECHNICAL PUBLICATIONS:** 

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales